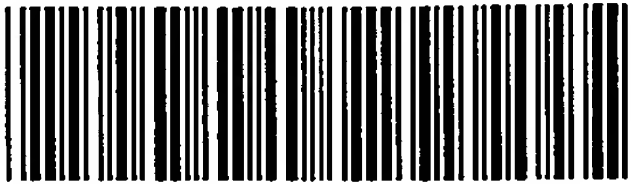
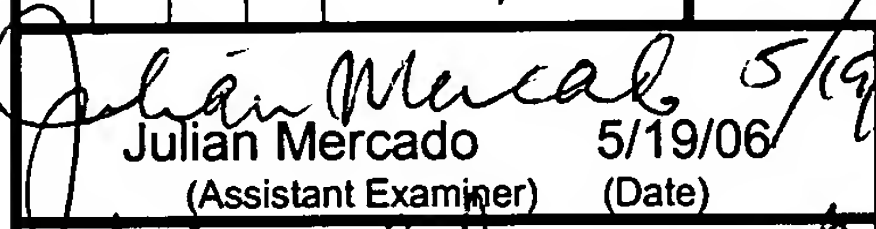

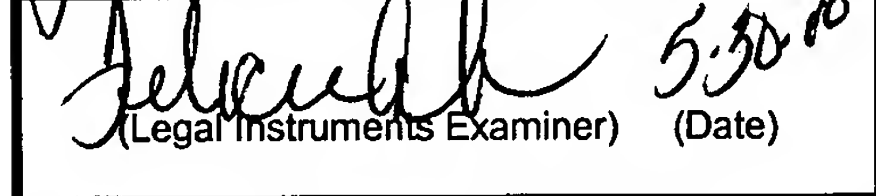


<b>Issue Classification</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/067,812	IWASAKI ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Julian Mercado	1745	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
429		17			429	19	22	34			
INTERNATIONAL CLASSIFICATION											
H	0	1	M	8/04							
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 Julian Mercado 5/19/06 (Assistant Examiner) (Date)					 PATRICK JOSEPH RYAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 5/06					Total Claims Allowed: 12	
										O.G. Print Claim(s)	O.G. Print Fig.
 (Legal Instruments Examiner) (Date) 5-30-06										1	1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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